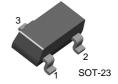


### PN100/PN100A/MMBT100/MMBT100A

### **NPN General Purpose Amplifier**

- This device is designed for general purpose amplifier applications at collector currents to 300mA.
- Sourced from process 10.





1. Emitter 2. Base 3. Collector Mark: PN100/PN100A

1. Base 2. Emitter 3. Collector Mark: N1/N1A

### Absolute Maximum Ratings\* T<sub>C</sub>=25°C unless otherwise noted

Symbol	Parameter		Value	Units
$V_{CEO}$	Collector-Emitter Voltage		45	V
V <sub>CBO</sub>	Collector-Base Voltage		75	V
V <sub>EBO</sub>	Emitter-Base Voltage		6.0	V
I <sub>C</sub>	Collector current	- Continuous	500	mA
T <sub>J</sub> , T <sub>stq</sub>	Junction and Storage Temperature		-55 ~ +150	°C

<sup>\*</sup> These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

- These ratings are based on a maximum junction temperature of 150 degrees C.
  These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

### Electrical Characteristics T<sub>C</sub>=25°C unless otherwise noted

Symbol	Parameter	Test Condition		Min.	Max.	Units
Off Charac	teristics	·				•
BV <sub>CBO</sub>	Collector-Base Breakdown Voltage	$I_C = 10\mu A, I_E = 0$		75		V
BV <sub>CEO</sub>	Collector-Emitter Breakdown Voltage *	$I_{C} = 1 \text{mA}, I_{B} = 0$		45		V
BV <sub>EBO</sub>	Emitter-Base Breakdown Voltage	$I_E = 10 \mu A, I_C = 0$		6.0		V
I <sub>CBO</sub>	Collector-Base Cutoff Current	V <sub>CB</sub> = 60V			50	nA
I <sub>CES</sub>	Collector-Emiitter Cutoff Current	V <sub>CE</sub> = 40V			50	nA
I <sub>EBO</sub>	Emitter Cutoff Current	V <sub>EB</sub> = 4V			50	nA
On Charac	teristics	•			ı	1
h <sub>FE</sub>	DC Current Gain	$I_C = 100\mu A, V_{CE} = 1.0V$ $I_C = 10mA, V_{CF} = 1.0V$	100 100A 100	80 240 100	450	
		$I_C = 100 \text{mA}, V_{CE} = 1.0 \text{V}^*$ $I_C = 150 \text{mA}, V_{CE} = 5.0 \text{V}^*$	100A 100 100A	300 100 100 100	600 350	
V <sub>CE(sat)</sub>	Collector-Emitter Saturation Voltage	$I_C = 10 \text{mA}, I_B = 1.0 \text{mA}$ $I_C = 200 \text{mA}, I_B = 20 \text{mA}$			0.2 0.4	V V
V <sub>BE(sat)</sub>	Base-Emitter Saturation Voltage	$I_C = 10 \text{mA}, I_B = 1.0 \text{mA}$ $I_C = 200 \text{mA}, I_B = 20 \text{mA}$			0.85 1.0	V V
Small Sign	nal Characteristics					
f <sub>T</sub>	Current Gain Bandwidth Product	$V_{CE} = 20V, I_{C} = 20mA$		250		MH
C <sub>obo</sub>	Output Capacitance	$V_{CB} = 5.0V, f = 1.0MHz$			4.5	pF
NF	Noise Figure	$I_C = 100\mu A$ , $V_{CE} = 5.0V$ $R_G = 2.0kΩ$ , $f = 1.0KHz$	100 100A		5.0 4.0	dB dB

# Thermal Characteristics $T_A=25^{\circ}C$ unless otherwise noted

		Ma			
Symbol	Parameter	PN100 PN100A	*MMBT100 *MMBT100A	Units	
P <sub>D</sub>	Total Device Dissipation	625	350	mW	
	Derate above 25°C	5.0	2.8	mW/°C	
$R_{\theta JC}$	Thermal Resistance, Junction to Case	83.3		°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	200	357	°C/W	

<sup>\*</sup> Device mounted on FR-4 PCB 1.6" × 1.6" × 0.06."

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## **Typical Characteristics**

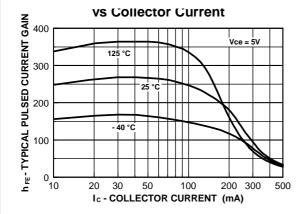


Figure 1. Typical Pulsed Current Gain vs Collector Current

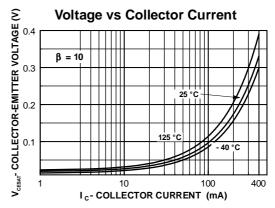


Figure 2. Collector-Emitter Saturation Voltage vs Collector Current

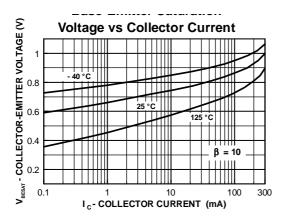


Figure 3. Base-Emitter Saturation Voltage vs Collector Current

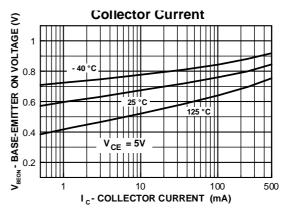


Figure 4. Base-Emitter On Voltage vs Collector Current

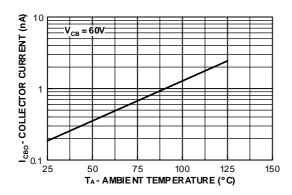


Figure 5. Collector Cutoff Current vs Ambient Temperature

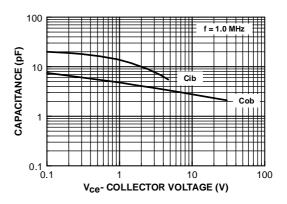


Figure 6. Input and Output Capacitance vs Reverse Voltag

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# Typical Characteristics (Continued)

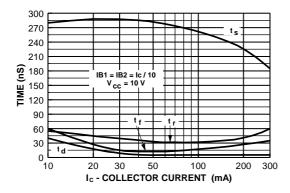


Figure 7. Switching Times vs Collector Current

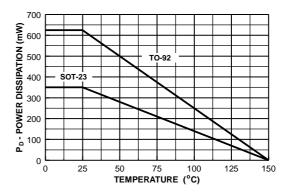
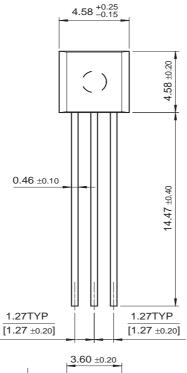


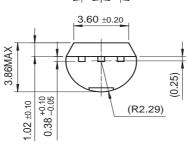
Figure 8. Power Dissipation vs Ambient Temperature

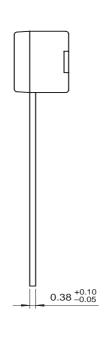
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# **Package Dimensions**

TO-92



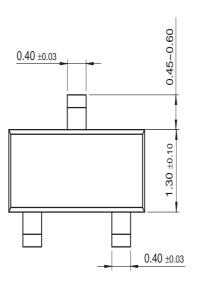


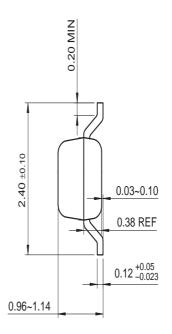


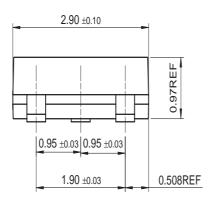
Dimensions in Millimeters

# Package Dimensions (Continued)

# SOT-23







Dimensions in Millimeters

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